

DK-105475-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

Intel[®] NUC (Mini PC)

INTEL CORPORATION

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2200 Mission College Blvd Santa Clara, CA 95054 USA

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233 JIN FENG RD NEW DISTRICT SUZHOU JIANGSU 215011

MAINTEK COMPUTER (SUZHOU) CO LTD

CB TEST CERTIFICATE

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Additional Information on page 2

19.5Vdc, 11.8A or 19.5Vdc, 16.9A

CHINA

Ratings and principal characteristics

Trademark / Brand (if any)

Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

of this Certificate

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part

IEC 60950-1:2005/AMD1:2009, IEC 60950-1:2005/AMD2:2013, IEC 60950-1:2005

ASL20082138 issued on 2020-11-02

Additional Information on page 2

NUC11PH, xNUC11PHx, xNUC11PHy

This CB Test Certificate is issued by the National Certification Body



See Page 2

Jan-Erik Storgaard

Ref. Certif. No.



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Model Details:

NUC11PH, xNUC11PHx, xNUC11PHy (where x and y can be a combination of alphanumeric characters or blank)

Additional Information: Additionally evaluated to EN 60950-1:2006 /A11:2009 /A1:2010 /A12:2011 / A2:2013. National Difference specified in the CB Test Report

Additional information (if necessary)



- UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
 - UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
 - UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN

UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA For full legal entity names see www.ul.com/ncbnames

Date: 2020-11-10

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Signature: Jan-Erik Storgaard

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